

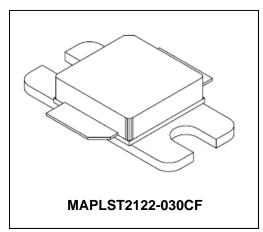
LDMOS RF Line Power FET Transistor 30 W, 2110-2170 MHz, 28V

M/A-COM Products Released - Rev. 07.07

Designed for W-CDMA base station applications in the 2.1 to 2.2 GHz frequency band. Suitable for TDMA, CDMA, and multicarrier power amplifier applications.

- 30W output power at P1dB (CW)
- 12dB minimum gain at P1dB (CW)
- W-CDMA typical performance: (28VDC, -45dBc ACPR @ 4.096MHz) Output power: 4.5W (typ.) Gain: 12dB (typ.) Efficiency: 16% (typ.)
- 10:1 VSWR ruggedness (CW @ 30W, 28V, 2110MHz)

Product Image



MAXIMUM RATINGS

Parameter	Symbol	Rating	Units
Drain—Source Voltage	V_{DSS}	65	V_{dc}
Gate—Source Voltage	V_{GS}	20	V_{dc}
Total Power Dissipation @ T _C = 25 °C	P₀	97	W
Storage Temperature	T _{stG}	-40 to +150	°C
Junction Temperature	TJ	+200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{eJC}	1.8	°C/W

NOTE—**CAUTION**—MOS devices are susceptible to damage from electrostatic charge. Precautions in handling and packaging MOS devices should be observed.

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Characteristic	Symbol	Min	Тур	Max	Unit
DC CHARACTERISTICS @ 25°C					
Drain-Source Breakdown Voltage ($V_{GS} = 0 \text{ Vdc}, I_D = 20 \mu \text{Adc}$)	V _{(BR)DSS}	65	_	_	Vdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 28 Vdc, V _{GS} = 0)	I _{DSS}	-	_	1	μAdc
Gate—Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0)	I _{GSS}	_		1	μAdc
Gate Threshold Voltage (V _{DS} = 10 Vdc, I _D = 1 mA)	$V_{\text{GS(th)}}$	2	1	4	Vdc
Gate Quiescent Voltage (V _{DS} = 28 Vdc, I _D = 250 mA)	$V_{DS(Q)}$	2	1	4.5	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 1 A)	V _{DS(on)}	١	0.2	ı	Vdc
Forward Transconductance (V _{GS} = 10 Vdc, I _D = 1 A)	Gm	_	1.2	1	S
DYNAMIC CHARACTERISTICS @ 25°C					
Input Capacitance (Including Input Matching Capacitor in Package) $(V_{DS} = 28 \text{ Vdc}, V_{GS} = 0, f = 1 \text{ MHz})$	C _{iss}	_	90	_	pF
Output Capacitance (V _{DS} = 28 Vdc, V _{GS} = 0, f = 1 MHz)	C _{oss}	_	32.5	_	pF
Reverse Transfer Capacitance (V _{DS} = 28 Vdc, V _{GS} = 0, f = 1 MHz)	C _{rss}	_	1.5	_	pF

⁽¹⁾ Device specifications obtained on a Production Test Fixture.

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RF FUNCTIONAL TESTS @ 25°C (In M/A-COM Test Fixture)					
Two-Tone Common-Source Amplifier Power Gain (V_{DS} = 28 Vdc, P_{OUT} = 30 W PEP, I_{DQ} = 250 mA, f1 = 2140.0 MHz, f2 = 2140.1 MHz)	G _{ps}	_	12.5		dB
Two-Tone Drain Efficiency $(V_{DS} = 28 \text{ Vdc}, P_{OUT} = 30 \text{ W PEP}, I_{DQ} = 250 \text{ mA}, f1 = 2140.0 \text{ MHz}, f2 = 2140.1 \text{ MHz})$	EFF (ŋ)	_	36	_	%
Two-Tone Common-Source Amplifier Power Gain (V _{DS} = 28 Vdc, P _{OUT} = 30 W PEP, I _{DQ} = 250 mA, f1 = 2140.0 MHz, f2 = 2140.1 MHz)	IMD		-30	-28	dBc
Input Return Loss (V_{DS} = 28 Vdc, P_{OUT} = 30 W PEP, I_{DQ} = 250 mA, f1 = 2140.0 MHz, f2 = 2140.1 MHz)	IRL	_	-12	_	dB
Two-Tone Common-Source Amplifier Power Gain (V_{DS} = 28 Vdc, P_{OUT} = 30 W PEP, I_{DQ} = 250 mA, f1 = 2110.0 MHz, f2 = 2110.1 MHz and f1 = 2170.0 MHz, f2 = 2170.1 MHz)	G _{ps}	_	12.5	_	dB
Two-Tone Drain Efficiency $(V_{DS} = 28 \text{ Vdc}, P_{OUT} = 30 \text{ W PEP}, I_{DQ} = 250 \text{ mA}, f1 = 2110.0 \text{ MHz}, f2 = 2110.1 \text{ MHz} and f1 = 2170.0 \text{ MHz}, f2 = 2170.1 \text{ MHz})$	EFF (ŋ)	_	36	_	%
Two-Tone Common-Source Amplifier Power Gain $(V_{DS} = 28 \text{ Vdc}, P_{OUT} = 30 \text{ W PEP}, I_{DQ} = 250 \text{ mA}, f1 = 2110.0 \text{ MHz}, f2 = 2110.1 \text{ MHz} and f1 = 2170.0 \text{ MHz}, f2 = 2170.1 \text{ MHz})$	IMD	_	-30	-28	dBc
Input Return Loss (V_{DS} = 28 Vdc, P_{OUT} = 30 W PEP, I_{DQ} = 250 mA, f1 = 2110.0 MHz, f2 = 2110.1 MHz and f1 = 2170.0 MHz, f2 = 2170.1 MHz)	IRL	_	-12	-9	dB
Output VSWR Tolerance (V _{DD} = 28 Vdc, P _{OUT} = 30 W, I _{DQ} = 250 mA, f = 2110 MHz, VSWR = 10:1, All Phase Angles at Frequency of Tests)	Ψ	No Degradation In Output Power Before and After Test			

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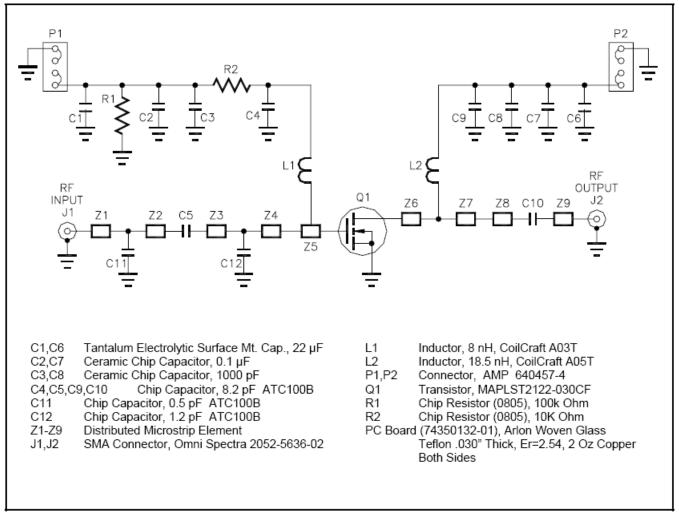


FIGURE 1. 2110—2170 MHZ TEST FIXTURE SCHEMATIC

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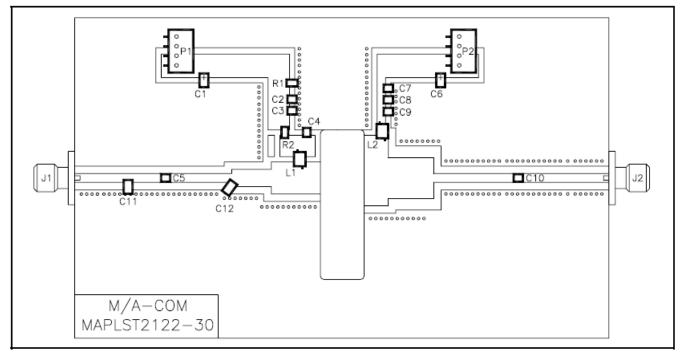


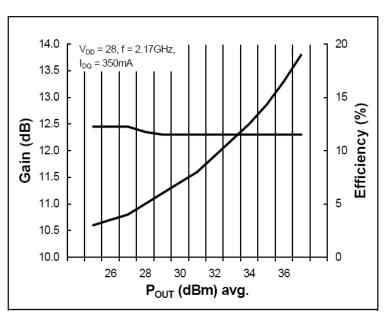
FIGURE 2. 2110—2170 MHZ TEST FIXTURE COMPONENT LAYOUT

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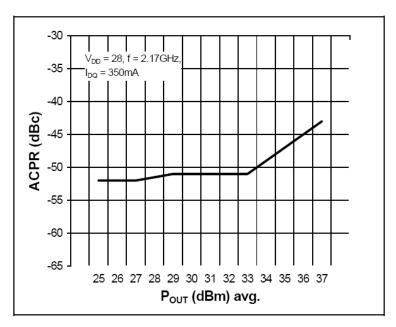
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GRAPH 1. W-CDMA: POWER GAIN AND DRAIN EFFICIENCY VS. OUTPUT POWER



GRAPH 2. W-CDMA: ADJACENT CHANNEL POWER RATIO VS. OUTPUT POWER

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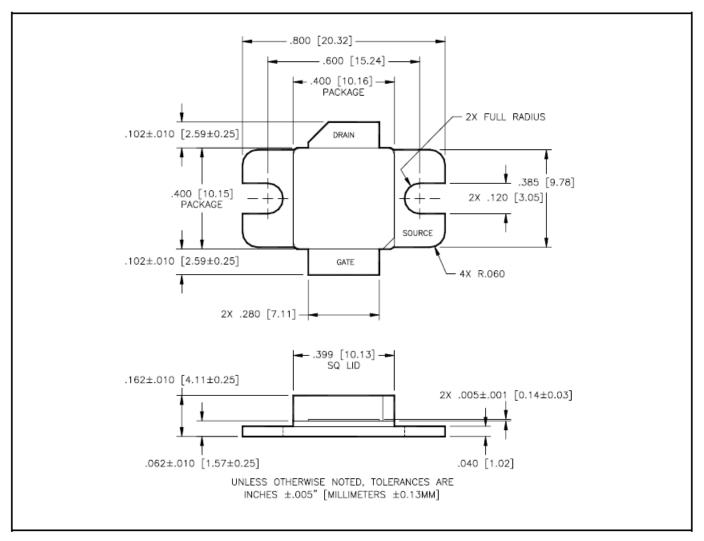
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